

Small-Signal Chip Diode

Features

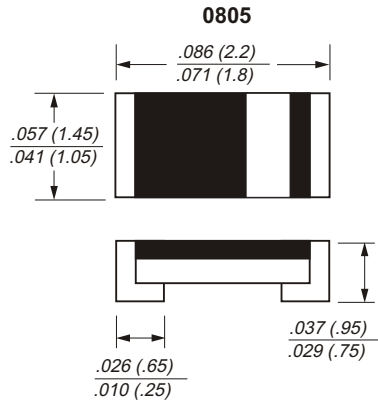
- This diode is also available in other case styles including the 1206 case with the type designation CD4148WP, the 0603 case with the type designation CD4148WTP
- Silicon Epitaxial Planar Diode
- Fast switching diode.

Mechanical Data

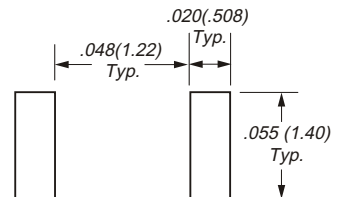
Case:0805

Weight : approx. 6 mg

Marking : Cathode band

*Dimensions in inches and (millimeters)*

Mounting Pad Layout



Absolute Maximum Ratings & Thermal Characteristics $T_{amb} = 25\text{ }^{\circ}\text{C}$, unless otherwise specified

| Parameter | Symbol | Value | Unit |
|---|-----------------|-------------------|--------------------|
| Reverse voltage | V_R | 75 | V |
| Peak reverse voltage | V_{RM} | 100 | V |
| Forward continuous current | I_{FM} | 300 | mA |
| Average rectified current sin half wave rectification with resistive load $f \geq 50\text{ Hz}$ | $I_{F(AV)}$ | 150 ¹⁾ | mA |
| Surge forward current $t < 1\text{ s}$ and $T_j = 25\text{ }^{\circ}\text{C}$ | I_{FSM} | 500 | mA |
| Power dissipation | P_{tot} | 400 ¹⁾ | mW |
| Typical Thermal Resistance Junction to Ambient Air | $R_{\theta JA}$ | 650 ¹⁾ | K/W |
| Junction temperature | T_j | 150 | $^{\circ}\text{C}$ |
| Storage temperature | T_S | - 65 to + 175 | $^{\circ}\text{C}$ |

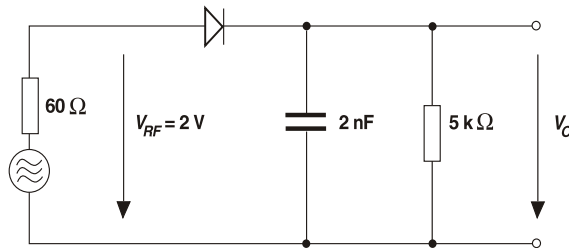
1) Valid provided that electrodes are kept at ambient temperature.



Electrical Characteristics $T_{amb} = 25\text{ }^\circ\text{C}$, unless otherwise specified

| Parameter | Symbol | Min | Max | Unit |
|--------------------------------|--|------|-----|------|
| Forward voltage | $I_F = 10\text{ mA}$ V_F | | 1.0 | V |
| Leakage current | $V_R = 20\text{ V}$ I_R | | 25 | nA |
| | $V_R = 75\text{ V}$ I_R | | 5.0 | eA |
| | $V_R = 20\text{ V}, T_J = 150\text{ }^\circ\text{C}$ I_R | | 50 | eA |
| Capacitance | $V_F = V_R = 0\text{ V}$ C_{tot} | | 4 | pF |
| Voltage rise when switching ON | tested with 50 mA pulses, $t_p = 0.1\text{ }\mu\text{s}$, rise time < 30 ns, $f_p = (5\text{ to }100)\text{ kHz}$ V_{fr} | | 2.5 | V |
| Reverse recovery time | $I_F = 10\text{ mA}$ to $I_R = 1\text{ mA}$, $V_R = 6\text{ V}, R_L = 100\text{ }\Omega$ t_{rr} | | 4 | ns |
| Rectification efficiency | $f = 100\text{ MHz}, V_{RF} = 2\text{ V}$ | 0.45 | | |

Rectification Efficiency Measurement Circuit



Typical Characteristics ($T_{amb} = 25\text{ }^\circ\text{C}$ unless otherwise specified)

Figure 1. Forward Characteristics

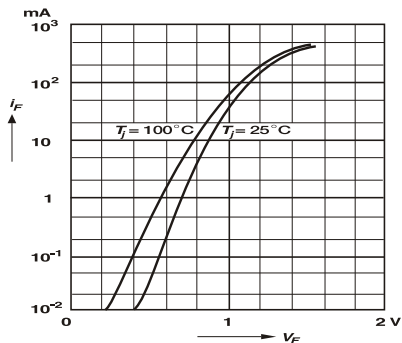


Figure 2. Dynamic Forward Resistance vs. Forward Current

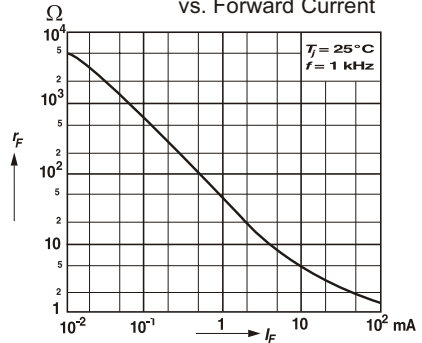




Figure 3. Admissible Power Dissipation vs. Ambient Temperature

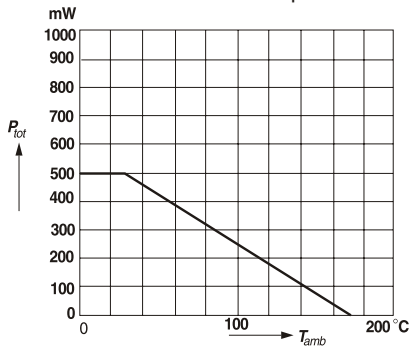


Figure 4. Relative Capacitance vs. Reverse Voltage

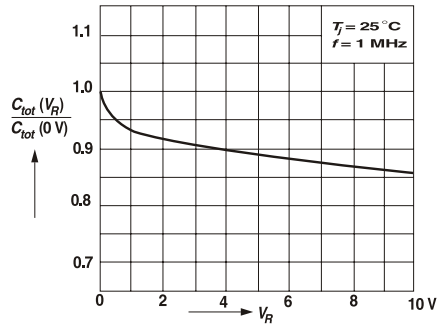


Figure 5. Leakage Current vs. Junction Temperature

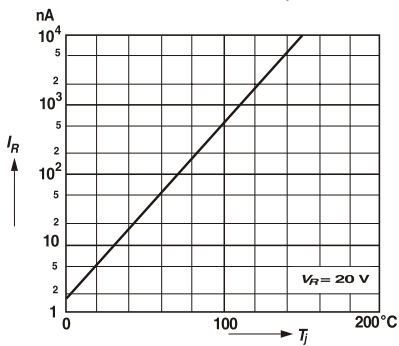
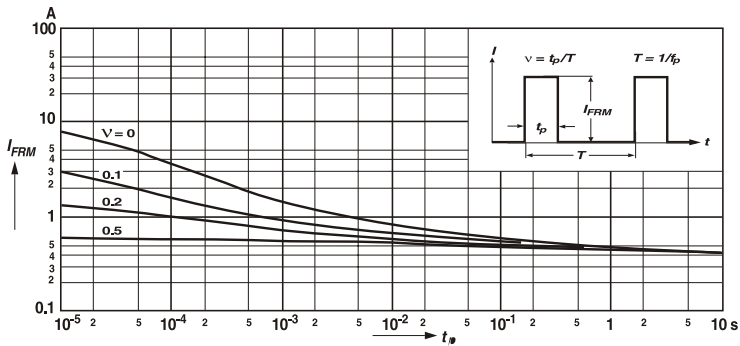


Figure 6. Admissible Repetitive Peak Forward Current vs. Pulse Duration





Device outlook

Shanghai plant (front side)



Kunshan plant (front side)



Shanghai plant (back side)



Kunshan plant (back side)

